



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 09/820,468
Filing Date March 28, 2001
Inventor Werner Juengling et al.
Assignee Micron Technology, Inc.
Group Art Unit 2812
Examiner Unknown
Attorney's Docket No. MI22-1599
Title: Methods of Forming Materials Between Conductive Electrical Components
and Insulating Materials

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -See Attached Form PTO-1449

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449, copies of which are attached. No admission is made regarding whether all the submitted references are prior art.

Citation of the referenced art is respectfully requested.

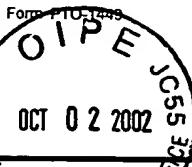
This Supplemental Information Disclosure Statement is being filed within three months of the filing date of the application or before the mailing date of a first Office Action, whichever occurs last. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: October 1, 2002

By:

Jennifer J. Taylor
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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

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09/820,468

LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT
Werner Juengling et al.

FILING DATE
March 28, 2001

GROUP
2812

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
AA	5,494,858	02-1996	Gnade et al.			
AB	5,723,368	03-1998	Cho et al.			
AC	5,380,679	01-1995	Kano			
AD	5,967,804	10-1999	Yoshizawa et al.			
AE	5,981,085	11-1999	Ninomiya et al.			
AF	6,347,446 B1	02-2002	Luthra et al.			
AG	5,298,311	03-1994	Bentson et al.			
AH	6,245,439 B1	06-2001	Yamada et al.			
AI						
AJ						
AK						
AL						

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FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AM							
AN							
AO							
AP							
AQ							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

	AR		
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.